

Notice of Allowability

Application No.

10/601,215

Examiner

John H Le

Applicant(s)

AGGARWAL, CHARU C.

Art Unit

2863

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address--

All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. **THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS.** This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.

1. ☐ This communication is responsive to ____.
2. ☒ The allowed claim(s) is/are 1-24.
3. ☒ The drawings filed on 20 June 2003 are accepted by the Examiner.
4. ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some* c) ☐ None of the:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. ____.
3. ☐ Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).
- * Certified copies not received: ____.

Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.

THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.

5. ☐ A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.
6. ☐ CORRECTED DRAWINGS (as "replacement sheets") must be submitted.
- (a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached
- 1) ☐ hereto or 2) ☐ to Paper No./Mail Date ____.
- (b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date ____.
- Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).
7. ☐ DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.

Attachment(s)

- | | |
|---|---|
| 1. <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 5. <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 2. <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 6. <input type="checkbox"/> Interview Summary (PTO-413),
Paper No./Mail Date ____. |
| 3. <input type="checkbox"/> Information Disclosure Statements (PTO-1449 or PTO/SB/08),
Paper No./Mail Date ____. | 7. <input type="checkbox"/> Examiner's Amendment/Comment |
| 4. <input type="checkbox"/> Examiner's Comment Regarding Requirement for Deposit
of Biological Material | 8. <input checked="" type="checkbox"/> Examiner's Statement of Reasons for Allowance |
| | 9. <input type="checkbox"/> Other ____. |

Reasons for Allowance

1. Claims 1-24 are allowed.
2. The following is an examiner's statement of reasons for allowance:

In combination with other limitations of the claims, the cited prior arts fails to teach the steps of creating wavelet decomposed segments of the at least one training time series data set; discretizing the wavelet decomposed segments of the at least one training time series data set; determining one or more frequent patterns in the discretized wavelet decomposed segments of the at least one training time series data set; determining rules from the one or more frequent patterns in the discretized wavelet decomposed segments; and classifying one or more frequent patterns in the at least one test time series data set according to the rules, as recited in claim(s) 1, 12, and 23.

U.S. Patent No. 6,735,550 discloses a system, method, and software products to classify a feature in time series data. The systems include a processing system and an interface where the interface receives the time series data. The method is for operating a processing system. The software product includes a storage system that stores application software that directs a processing system. The processing system is configured to: process the time series data with a plurality of membership functions to generate a plurality of hypersurfaces, process the hypersurfaces to generate a composite hypersurface, process the composite hypersurface to identify clusters, and process the clusters to classify the feature. '550 fails to specify the steps of creating wavelet decomposed segments of the at least one training time series data set; discretizing the wavelet decomposed segments of the at least one training time series

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data set; determining one or more frequent patterns in the discretized wavelet decomposed segments of the at least one training time series data set; determining rules from the one or more frequent patterns in the discretized wavelet decomposed segments; and classifying one or more frequent patterns in the at least one test time series data set according to the rules, as now recited in claims 1, 12, and 23 of the present invention.

U.S. Patent No. 5,848,193 discloses a computer vision system having improved means for characterizing the parameters of edge segments of an unknown object is disclosed. The unknown object is transformed by a digital camera into an image and transformed by a wavelet projection transform so as to decompose the unknown objects into their constituent multi-scale edge segment features and provide recognition of the unknown object by relating their constituent edge features to each other. '193 fails to specify the steps of creating wavelet decomposed segments of the at least one training time series data set; discretizing the wavelet decomposed segments of the at least one training time series data set; determining one or more frequent patterns in the discretized wavelet decomposed segments of the at least one training time series data set; determining rules from the one or more frequent patterns in the discretized wavelet decomposed segments; and classifying one or more frequent patterns in the at least one test time series data set according to the rules, as now recited in claims 1, 12, and 23 of the present invention.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably

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accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Contact Information

3. Any inquiry concerning this communication or earlier communications from the examiner should be directed to John H. Le whose telephone number is 571-272-2275. The examiner can normally be reached on 7:00 - 3:30.

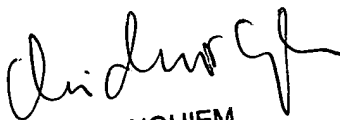
If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John E Barlow can be reached on 571-272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

John H. Le

Patent Examiner-Group 2863

November 6, 2004


MICHAEL NGHIEM
PRIMARY EXAMINER
11/10/04